

Notice of References Cited

Application/Control No.

10/524,216

Applicant(s)/Patent Under
Reexamination
CHOWDHRY ET AL.

Examiner

Rip A. Lee

Art Unit

1713

Page 1 of 1


U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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*	N	WO 01/44325 A1	06-2001	International	Kristen et al.	C08F 10/02
	O					
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NON-PATENT DOCUMENTS

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